

<b>Notice of References Cited</b>	Application/Control No. 10/622,061	Applicant(s)/Patent Under Reexamination MIYABE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0174753	09-2003	Yabuki et al.	372/50
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